

N-channel TrenchMOS standard level FET Rev. 2 — 2 February 2011

Product data sheet

1. **Product profile**

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- AEC Q101 compliant
- Low conduction losses due to low on-state resistance
- 1.3 Applications
 - 12 V, 24 V and 42 V loads
 - Automotive and general purpose power switching

1.4 Quick reference data

Table 1 Quick reference data

Table 1.	Quick reference da	lta				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	75	V
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; see <u>Figure 1</u> ; see <u>Figure 3</u>	-	-	53	A
P _{tot}	total power dissipation	$T_{mb} = 25 \text{ °C}; \text{ see } \frac{\text{Figure 2}}{\text{Figure 2}}$	-	-	138	W
Static cha	aracteristics					
R _{DSon}	drain-source on-state resistance	$\label{eq:VGS} \begin{array}{l} V_{GS} = 10 \; V; \; I_{D} = 25 \; A; \\ T_{j} = 175 \; ^{\circ}C; \; see \; \underline{Figure \; 12}; \\ see \; \underline{Figure \; 13} \end{array}$	-	-	49	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } Figure 12;$ see Figure 13	-	17	23	mΩ
Avalanch	e ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$ \begin{split} I_D &= 49 \text{ A}; \text{V}_{\text{sup}} \leq 75 \text{V}; \\ R_{\text{GS}} &= 50 \Omega; \text{V}_{\text{GS}} = 10 \text{V}; \\ T_{j(\text{init})} &= 25 ^{\circ}\text{C}; \text{ unclamped} \end{split} $	-	-	120	mJ



Motors, lamps and solenoids

sources

Suitable for standard level gate drive

Suitable for thermally demanding environments due to 175 °C rating

N-channel TrenchMOS standard level FET

2. Pinning information

Table 2.	Pinning	j information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		_
2	D	drain	mb	
3	S	source		
mb	D	mounting base; connected to drain		mbb076 S
			SOT404 (D2PAK)	

3. Ordering information

Table 3. Ordering i	nformation		
Type number	Package		
	Name	Description	Version
BUK7623-75A	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

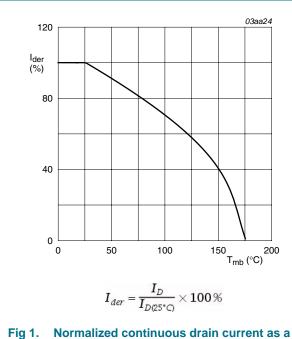
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4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	75	V
V _{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	-	75	V
V _{GS}	gate-source voltage		-20	20	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 10 V; see <u>Figure 1</u> ; see <u>Figure 3</u>	-	53	А
		T_{mb} = 100 °C; V_{GS} = 10 V; see <u>Figure 1</u>	-	37	А
I _{DM}	peak drain current	T _{mb} = 25 °C; pulsed; t _p ≤ 10 μs; see <u>Figure 3</u>	-	213	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	138	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Source-drai	n diode				
I _S	source current	T _{mb} = 25 °C	-	53	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$	-	213	А
Avalanche r	ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	I_D = 49 A; V _{sup} ≤ 75 V; R _{GS} = 50 Ω; V _{GS} = 10 V; T _{j(init)} = 25 °C; unclamped	-	120	mJ



function of mounting base temperature

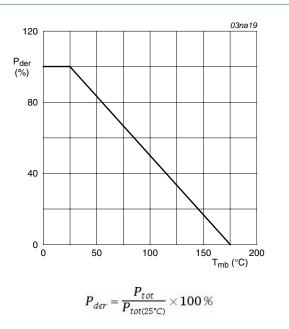
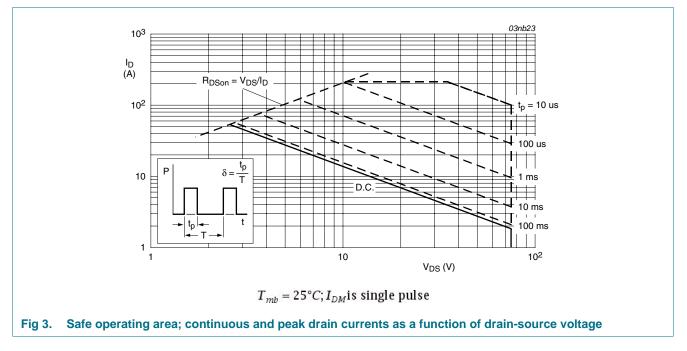


Fig 2. Normalized total power dissipation as a function of mounting base temperature

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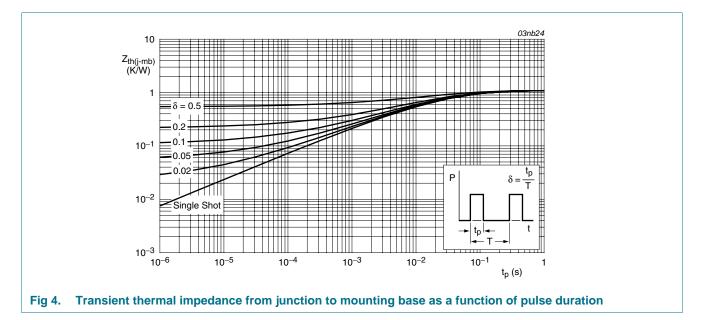
N-channel TrenchMOS standard level FET



5. Thermal characteristics

Table 5.Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{\text{th}(j\text{-mb})}$	thermal resistance from junction to mounting base	see Figure 4	-	-	1.1	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	minimum footprint; mounted on a printed-circuit board	-	50	-	K/W

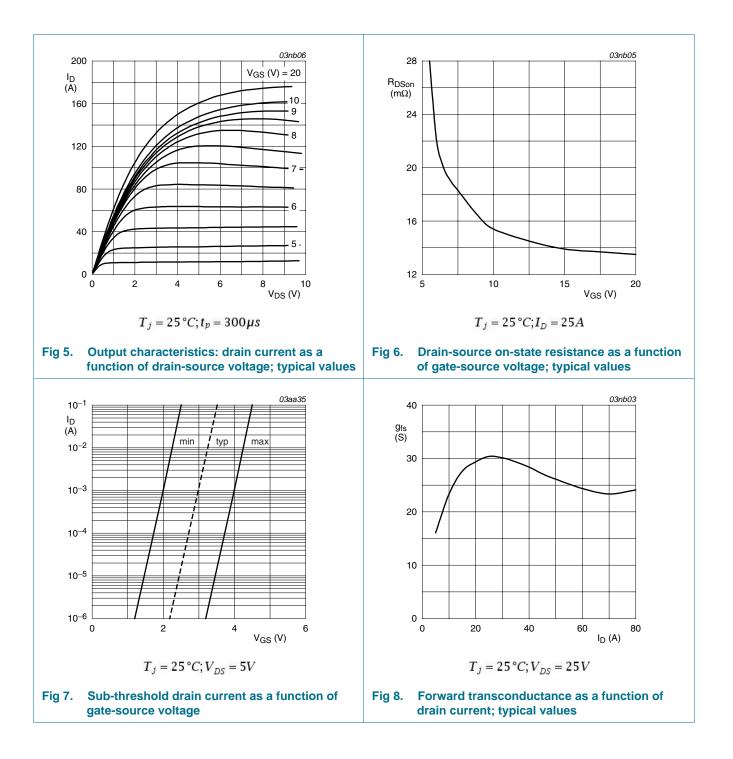


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6. Characteristics

Static characteristics V(BR)DSS drain-source breakdown voltage I _D = 0.25 mA; V _{GS} = 0 V; T _j = 25 °C 75 - V _{GS(th}) gate-source threshold voltage I _D = 1 mA; V _{DS} = V _{GS} ; T _j = -55 °C; see Figure 11 - - - I _D = 1 mA; V _{DS} = V _{GS} ; T _j = -55 °C; 2 3 - <t< th=""><th>- - 4.4 4</th><th>Unit V V V V</th></t<>	- - 4.4 4	Unit V V V V
	- 4.4 4 -	V V V
	- 4.4 4 -	V V V
$V_{GS(th)} \qquad gate-source threshold voltage \qquad I_D = 0.25 \text{ H/K}, \forall Q_S = 0.7, I_J = 0.5 \text{ C} \qquad from the equation of the equ$	4.4 4 -	VV
voltage see Figure 11 $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 ^\circ\text{C};$ 2 3 $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 ^\circ\text{C};$ 1 - $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 ^\circ\text{C};$ 1 - $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 ^\circ\text{C};$ 1 - $I_D = 1 \text{ mA}; V_{DS} = 75 ^\circ\text{V}; V_{GS} = 0 ^\circ\text{V}; T_j = 175 ^\circ\text{C};$ 1 - I_{DSS} drain leakage current $V_{DS} = 75 ^\circ\text{V}; V_{GS} = 0 ^\circ\text{V}; T_j = 25 ^\circ\text{C};$ - 0.05 I_{GSS} gate leakage current $V_{GS} = 20 ^\circ\text{V}; V_{DS} = 0 ^\circ\text{V}; T_j = 25 ^\circ\text{C};$ - 2 R_{DSon} drain-source on-state resistance $V_{GS} = 10 ^\circ\text{V}; I_D = 25 ^\circ\text{A}; T_j = 175 ^\circ\text{C};$ - - $N_{GS} = 10 ^\circ\text{V}; I_D = 25 ^\circ\text{A}; T_j = 25 ^\circ\text{C};$ - 17 2 $V_{GS} = 10 ^\circ\text{V}; I_D = 25 ^\circ\text{A}; T_j = 25 ^\circ\text{C};$ - 17 2 $N_{GS} = 10 ^\circ\text{V}; I_D = 25 ^\circ\text{A}; T_j = 25 ^\circ\text{C};$ - 17 2 $V_{GS} = 10 ^\circ\text{V}; I_D = 25 ^\circ\text{A}; T_j = 25 ^\circ\text{C};$ - 17 2 $N_{GS} = 10 ^\circ\text{V}; I_D = 25 ^\circ\text{A}; T_j = 25 ^\circ\text{C};$ - 17 2 <td< td=""><td>4</td><td>V</td></td<>	4	V
$\frac{\text{see Figure 11}}{I_D = 1 \text{ mA; } V_{DS} = V_{GS}; T_j = 175 \text{ °C;} \qquad 1 \qquad - \qquad \cdot \qquad \cdot$	-	
$see \frac{Figure 11}{I_{DSS}}$ $drain leakage current$ $V_{DS} = 75 \text{ V}; \text{ V}_{GS} = 0 \text{ V}; \text{ T}_{j} = 175 ^{\circ}\text{C}$ $ 48 ^{\circ}^{}$		V
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$		•
$\begin{array}{c c} I_{GSS} & gate leakage current \\ I_{GS} & gate leakage current \\ R_{DSon} & drain-source on-state \\ resistance \\ \end{array} \begin{array}{c} V_{GS} = 20 \ V; \ V_{DS} = 0 \ V; \ T_j = 25 \ ^\circ C & - & 2 \\ \hline V_{GS} = -20 \ V; \ V_{DS} = 0 \ V; \ T_j = 25 \ ^\circ C & - & 2 \\ \hline V_{GS} = 10 \ V; \ I_D = 25 \ A; \ T_j = 175 \ ^\circ C; \\ see \ Figure 12; \ see \ Figure 13 \\ \hline V_{GS} = 10 \ V; \ I_D = 25 \ A; \ T_j = 25 \ ^\circ C; \\ see \ Figure 12; \ see \ Figure 13 \\ \hline Dynamic characteristics \\ \hline C_{iss} & input \ capacitance \\ \hline V_{GS} = 0 \ V; \ V_{DS} = 25 \ V; \ f = 1 \ MHz; \\ \hline T_{C} = 25 \ ^\circ C \ Figure 14 \\ \hline \end{array}$	500	μA
$V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C} - 2$ $R_{DSon} \qquad \text{drain-source on-state} \\ \text{resistance} \qquad V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 175 \text{ °C}; \\ \text{see Figure 12}; \text{see Figure 13} \\ V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C}; \\ \text{see Figure 12}; \text{see Figure 13} \\ \hline V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C}; \\ \text{see Figure 12}; \text{see Figure 13} \\ \hline Dynamic characteristics \\ C_{iss} \qquad \text{input capacitance} \qquad V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}; \\ T = 25 \text{ °C} \text{ constrained} \text{ MHz}; \\ \hline T = 25 \text{ °C} \text{ constrained} \text{ MHz}; \\ \hline T = 25 \text{ °C} \text{ constrained} \text{ MHz}; \\ \hline T = 25 \text{ °C} \text{ constrained} \text{ MHz}; \\ \hline T = 25 \text{ °C} \text{ constrained} \text{ MHz}; \\ \hline T = 25 \text{ °C} \text{ constrained} \text{ MHz}; \\ \hline T = 25 \text{ °C} \text{ constrained} \text{ MHz}; \\ \hline T = 25 \text{ °C} \text{ constrained} \text{ MHz}; \\ \hline T = 25 \text{ °C} \text{ constrained} \text{ MHz}; \\ \hline T = 25 \text{ °C} \text{ constrained} \text{ MHz}; \\ \hline T = 25 \text{ °C} \text{ constrained} \text{ MHz}; \\ \hline T = 25 \text{ °C} \text{ constrained} \text{ MHz}; \\ \hline T = 25 \text{ °C} \text{ constrained} \text{ MHz}; \\ \hline T = 25 \text{ °C} \text{ constrained} \text{ MHz}; \\ \hline T = 25 \text{ °C} \text{ constrained} \text{ mathematicatione} \text{ Constrained} \text{ mathematicatione} mathem$	10	μA
$ \begin{array}{c} R_{DSon} \\ R_{DSon} \\ resistance \end{array} \qquad \begin{array}{c} V_{GS} = 10 \; V; \; I_{D} = 25 \; A; \; T_{j} = 175 \; ^{\circ}C; \\ see \; \frac{Figure 12}{Figure 12}; \; see \; \frac{Figure 13}{Figure 13} \\ V_{GS} = 10 \; V; \; I_{D} = 25 \; A; \; T_{j} = 25 \; ^{\circ}C; \\ see \; \frac{Figure 12}{Figure 12}; \; see \; \frac{Figure 13}{Figure 13} \end{array} \qquad \begin{array}{c} - & - & - & - \\ 17 & - & - & - \\ See \; \frac{Figure 12}{Figure 12}; \; see \; \frac{Figure 13}{Figure 13} \end{array} \end{array} $	100	nA
$\begin{array}{c} \text{resistance} & \text{see } \overline{Figure \ 12}; \text{ see } \overline{Figure \ 13} \\ & V_{GS} = 10 \ V; \ I_D = 25 \ A; \ T_j = 25 \ ^\circ\text{C}; & - & 17 \\ & \text{see } \overline{Figure \ 12}; \text{ see } \overline{Figure \ 13} \end{array}$	100	nA
see Figure 12; see Figure 13 Dynamic characteristics C_{iss} input capacitance $V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; \text{f} = 1 \text{ MHz};$ - 1789 25 PC Page Figure 14	49	mΩ
C_{iss} input capacitance $V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;$ - 1789	23	mΩ
C_{oss} output capacitance $T_j = 25 \text{ °C}$; see Figure 14 - 382	2385	pF
	458	pF
C _{rss} reverse transfer - 219 : capacitance	300	pF
	-	ns
t_r rise time $R_{G(ext)} = 10 \Omega; T_j = 25 °C$ - 66	-	ns
t _{d(off)} turn-off delay time - 61 ·	-	ns
t _f fall time - 41 ·	-	ns
L_D internal drain from drain lead 6 mm from package to - 4.5 - inductance centre of die; $T_j = 25 \ ^\circ C$	-	nH
from upper edge of drain mounting base - 2.5 to centre of die; $T_j = 25 \text{ °C}$	-	nH
L _S internal source from source lead to source bond pad - 7.5 - inductance	-	nH
Source-drain diode		
V_{SD} source-drain voltage $I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C};$ - 0.85 see Figure 15	1.2	V
		ns
Q_r recovered charge $V_{GS} = -10 V; V_{DS} = 30 V; T_j = 25 °C$ - 144	-	nC

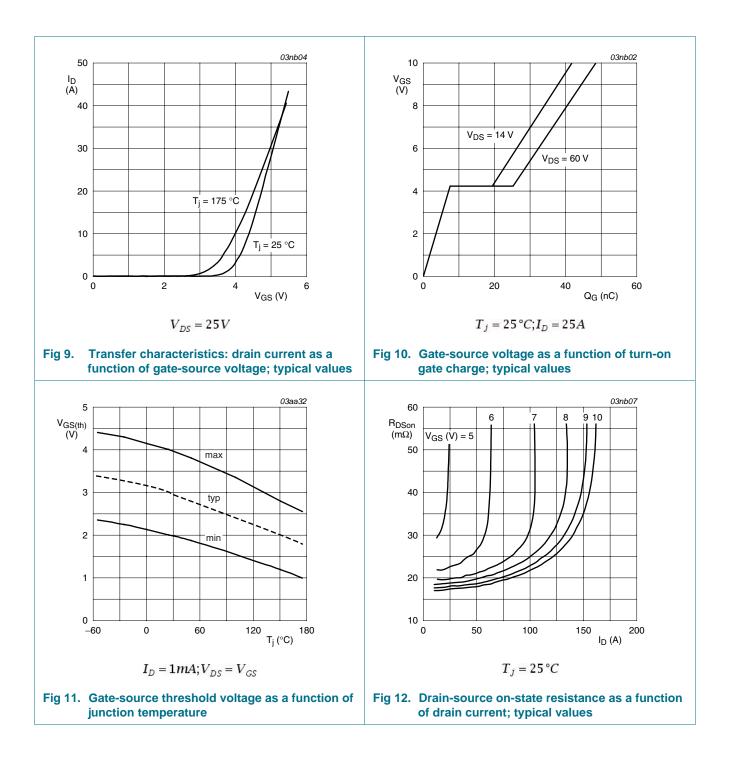
N-channel TrenchMOS standard level FET



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N-channel TrenchMOS standard level FET

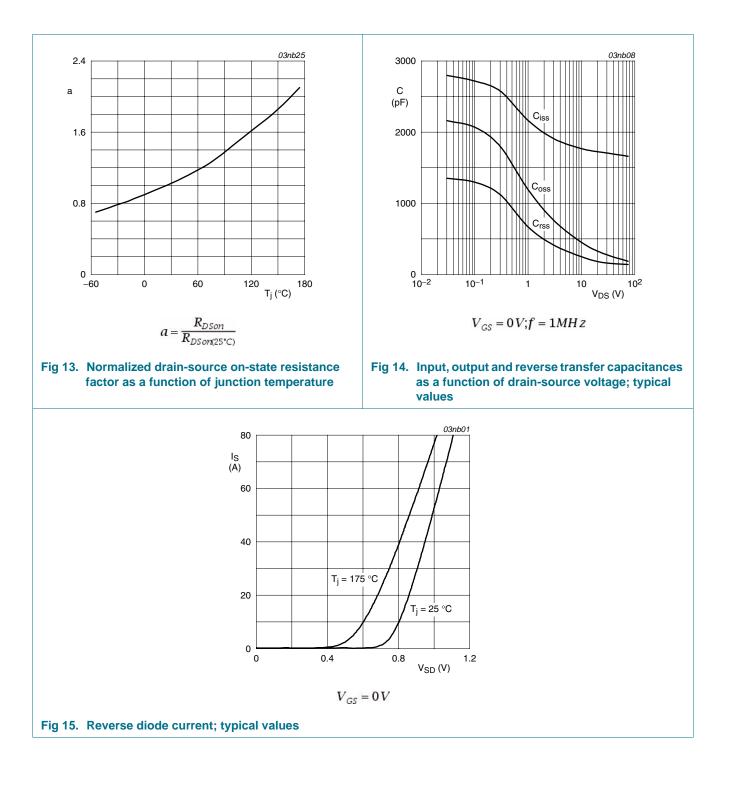


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7. Package outline

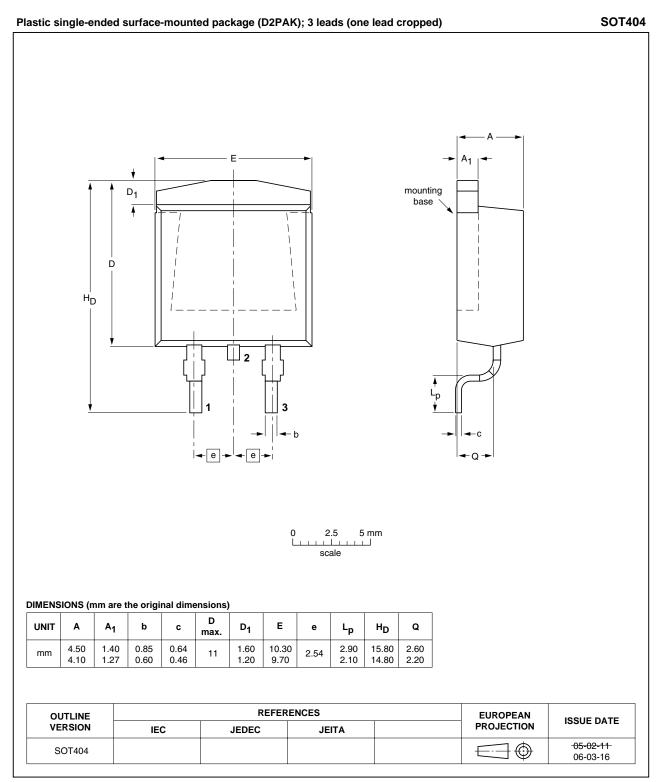


Fig 16. Package outline SOT404 (D2PAK)

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BUK7623-75A

N-channel TrenchMOS standard level FET

8. Revision history

Table 7. Revision histor	У			
Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK7623-75A	20110202	Product data sheet	-	BUK7523_7623_75A-01
Modifications:		of this data sheet has b of NXP Semiconductors	•	omply with the new identity
	 Legal texts 	have been adapted to t	he new company na	me where appropriate.
	 Type numb 	er BUK7623-75A separ	ated from data shee	t BUK7523_7623_75A-01.
BUK7523_7623_75A-01	20001009	Product specification	-	-

N-channel TrenchMOS standard level FET

9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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BUK7623-75A

N-channel TrenchMOS standard level FET

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12 of 13

N-channel TrenchMOS standard level FET

11. Contents

1	Product profile
1.1	General description1
1.2	Features and benefits1
1.3	Applications1
1.4	Quick reference data1
2	Pinning information2
3	Ordering information2
4	Limiting values3
5	Thermal characteristics4
6	Characteristics5
7	Package outline9
8	Revision history10
9	Legal information11
9.1	Data sheet status11
9.2	Definitions11
9.3	Disclaimers
9.4	Trademarks12
10	Contact information12

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